

Notic of Ref renc s Cited	Application/Control No. 10/705,174		Applicant(s)/Patent Under Reexamination MITCHELL ET AL.	
	Examiner Yoon-Young Kim		Art Unit 1723	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,827,854 B2	12-2004	Mitchell et al.	210/263
*	B	US-6,565,749 B1	05-2003	Hou et al.	210/500.38
*	C	US-6,660,166 B2	12-2003	Tremblay et al.	210/694
*	D	US-6,241,893 B1	06-2001	Levy, Ehud	210/660
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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